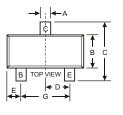
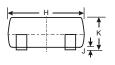
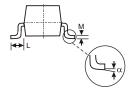


Features

- Epitaxial Planar Die Construction
- Complementary PNP Type Available MMBT3906
- Ideal for Medium Power Amplification and Switching
- We declare that the material of product compliance with RoHS requirements.
- Marking Code:1AM







SOT-23					
Dim	Min	Max			
Α	0.37	0.51			
В	1.20	1.40			
С	2.30	2.50			
D	0.89	1.03			
Е	0.45	0.60			
G	1.78	2.05			
Н	2.80	3.00			
J	0.013	0.10			
K	0.903	1.10			
L	0.45	0.61			
М	0.085	0.180			
α	0°	8°			
All Dimensions in mm					

Maximum Ratings @ T_A = 25°C unless otherwise specified

Parameter	Symbol	Limits	Unit
Collector–Emitter Voltage	VCEO	40	Vdc
Collector–Base Voltage	VCBO	60	Vdc
Emitter–Base Voltage	VEBO	6	Vdc
Collector Current — Continuous	IC	200	mAdc

• THERMAL CHARACTERISTICS

Total Device Dissipation, FR-5 Board (Note 1) @ TA = 25°C Derate above 25°C	PD	225 1.8	mW mW/℃
Thermal Resistance, Junction–to–Ambient(Note 1)	ROJA	556	°C/W
Total Device Dissipation, Alumina Substrate (Note 2) @ TA =25°C Derate above 25°C	PD	300 2.4	mW mW/℃
Thermal Resistance, Junction–to–Ambient(Note 2)	ROJA	417	°C/W
Junction and Storage temperature	TJ,Tstg	- 55∼+150	$^{\circ}\mathbb{C}$

^{1.} $FR-5 = 1.0 \times 0.75 \times 0.062$ in.

^{2.} Alumina = $0.4 \times 0.3 \times 0.024$ in. 99.5% alumina.





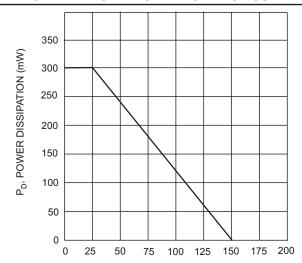
Electrical Chara	acteristics @ TA = 25°C unless oth	erwise specifie	d			
OFF CHARACTE						
Characteristic	INO FIGO	Symbol	Min.	Тур.	Max.	Unit
Collector–Emitter Breakdown Voltage		\/DD/(050)	10			.,
(IC = 1.0 mAdc, IB =	•	VBR(CEO)	40		_	V
Collector–Base Breakdown Voltage (IC = 10 µAdc, IE = 0)		VBR(CBO)	60	_	_	V
Emitter-Base Break	•	\/DD/EDO\	6			.,
(IE = 10 μAdc, IC = 0 Collector Cutoff Curr	· ·	VBR(EBO)	0	_	_	V
*	(VCE = 30 Vdc, VEB = 3.0Vdc)		_	-	50	nA
Base Cutoff Current (VCE = 30 Vdc, VEE		IBL	_	_	50	n ^
·	RISTICS (Note 3.)					l nA
DC Current Gain						
(IC = 0.1 mAdc, VCI	≣ = 1.0 Vdc)		40	_	_	
(IC = 1.0 mAdc, VCI	•	HFE	70	_	_	
(IC = 10 mAdc, VCE	•	III L	100	_	300	
(IC = 50 mAdc, VCE	, ·		60	_	300	
(IC = 100 mAdc, VC	*			_	_	
Collector–Emitter Sa	*		30	_	 -	
(IC = 10 mAdc, IB =	• , ,	VCE(sat)	_	_	0.2	V
(IC = 50mAdc, IB = 5	,	VOL(out)	_	_	0.2	ľ
Base-Emitter Satura	· · · · · · · · · · · · · · · · · · ·				0.5	
	<u> </u>	\/DE(a.at)	0.05		0.05	\ \ \
(IC = 10 mAdc, IB =	*	VBE(sat)	0.65	_	0.85	\ \ \
(IC = 50mAdc, IB = 5	·		_	_	0.95	
Characteristic	CHARACTERISTICS	Cumbal	Min.	Tvn	Max.	Unit
	adwidth Draduat	Symbol fT	IVIII I .	Тур.	IVIAX.	
Current–Gain — Bandwidth Product (IC = 10mAdc, VCE= 20Vdc, f = 100MHz)		''	300	ı	_	MHz
Output Capacitance (VCB = 5.0 Vdc, IE = 0, f = 1.0 MHz)		Cobo	-	_	4	pF
Input Capacitance (VEB = 0.5 Vdc, IC = 0, f = 1.0 MHz)		Cibo	_	_	8	pF
Input Impedance	4.0 4.4 - 4.0	hie	1		10	kΩ
1	1.0 mAdc, f = 1.0 kHz)	.	'		10	
Voltage Feedback Ratio (VCE= 10 Vdc, IC = 1.0 mAdc, f = 1.0 kHz)		hre	0.5	_	8	X 10 ⁻⁴
Small–Signal Current Gain		hfe				
(VCE= 10 Vdc, IC = 1.0 mAdc, f = 1.0 kHz)		""	100	_	400	
Output Admittance		hoe				μmhos
(VCE= 10 Vdc, IC = 1.0 mAdc, f = 1.0 kHz)		1100	1	-	40	риноз
Noise Figure		NF			_	dB
(VCE=5V, IC=100μA, RS=1.0kΩ ,f =1.0kHz)				_	5	
SWITCHING CHA	ARACTERISTICS					
Delay Time	(VCC = 3.0 Vdc, VBE= - 0.5Vdc,	td	_	-	35	
Rise Time	IC = 10 mAdc, IB1 = 1.0 mAdc)	tr	_	_	35	ns
Storage Time	(VCC = 3.0 Vdc, IC = 10 mAdc,	ts	-	_	200	
Fall Time	IB1 = I B2 = 1.0 mAdc)	tf	_	_	50	

^{3.} Pulse Test: Pulse Width <300 µs, Duty Cycle <2.0%.

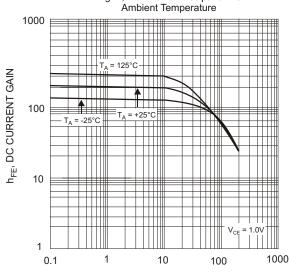




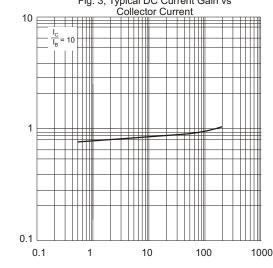
TYPICAL TRANSIENT CHARACTERISTICS



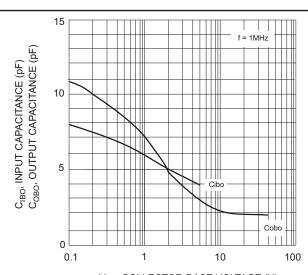
T_A, AMBIENT TEMPERATURE (°C) Fig. 1, Max Power Dissipation vs Ambient Temperature



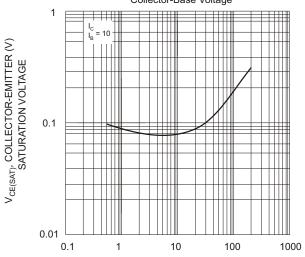
I_C, COLLECTOR CURRENT (mA) Fig. 3, Typical DC Current Gain vs



I_C, COLLECTOR CURRENT (mA) Fig. 5, Typical Base-Emitter Saturation Voltage vs. Collector Current



V_{CB}, COLLECTOR-BASE VOLTAGE (V) Fig. 2, Input and Output Capacitance vs. Collector-Base Voltage



I_C, COLLECTOR CURRENT (mA) Fig. 4, Typical Collector-Emitter Saturation Voltage vs. Collector Current

V_{BE(SAT)}, BASE-EMITTER (V) SATURATION VOLTAGE





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